

# Phasing Methods for Structure Completion in Crystallography



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## Structure Completion

Measured Intensities

$$I_g = |A_g|^2$$

where

$$A_g = R_g + O_g$$

$$R_g = \sum_j n_j \exp(ig \cdot r_j)$$

$$O_g = \sum_j u_j \exp(ig \cdot r_j)$$

## Problem

Find  $\{u_j\}$  (or equivalently  $O_g$ )

given  $\{I_g\}$  and  $\{R_g\}$

Analogous to *holography*

A. Szoke, Phys. Rev. B 47, 14044 (1993)

## Direct Solution for Unknown Electron Density

$$I_g = |F_g|^2 = |R_g + O_g|^2$$

Since

$$O_g = \sum_j u_j \exp(ig \cdot r_j)$$

$$I_g - |R_g|^2 = 2 \sum_j u_j \operatorname{Re} [ R_g^* \exp\{ig \cdot r_j\}] + \sum_{j,l} u_j u_l \exp\{ig \cdot (r_j - r_l)\} \quad \forall g$$

Methods for solving these Eqns. directly have been given by e.g.:

- A. Szöke, *Phys. Rev. B* **47**, 14044 (1993)
- D. K. Saldin *et al.*, *Phys. Rev. Lett.* **70**, 1112 (1993)
- A. Szöke, *Acta Cryst. A* **53**, 291 (1997)

## Solution by Phasing Methods

$$u_j = \frac{1}{N} \sum_g \left[ |F_g| \exp\{i \phi_g\} - R_g \right] \exp(-g \cdot r_j)$$

Problem is that  $\phi_g$  is not known from experiment (phase problem)

## Unweighted Difference Fourier

W. Cochran, *Acta Cryst.* **4**, 408 (1951)

$$u_j = \frac{1}{N} \sum_g \left[ |F_g| \exp\{i \phi_g^{(R)}\} - R_g \right] \exp(-g \cdot r_j)$$

$$\phi_g^{(R)} = \arg(R_g)$$

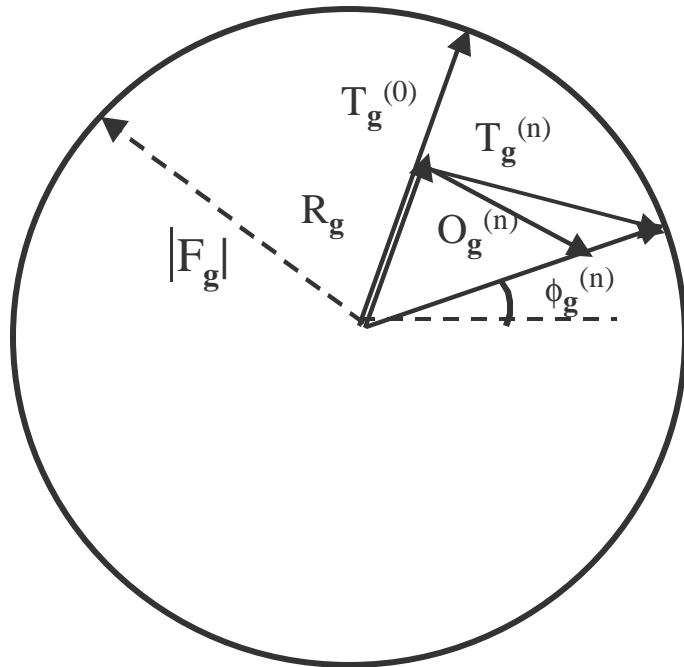
## Weighted Difference Fourier

G. Sim, *Acta Cryst.* **12**, 813 (1959); *ibid.* **13**, 511 (1960)

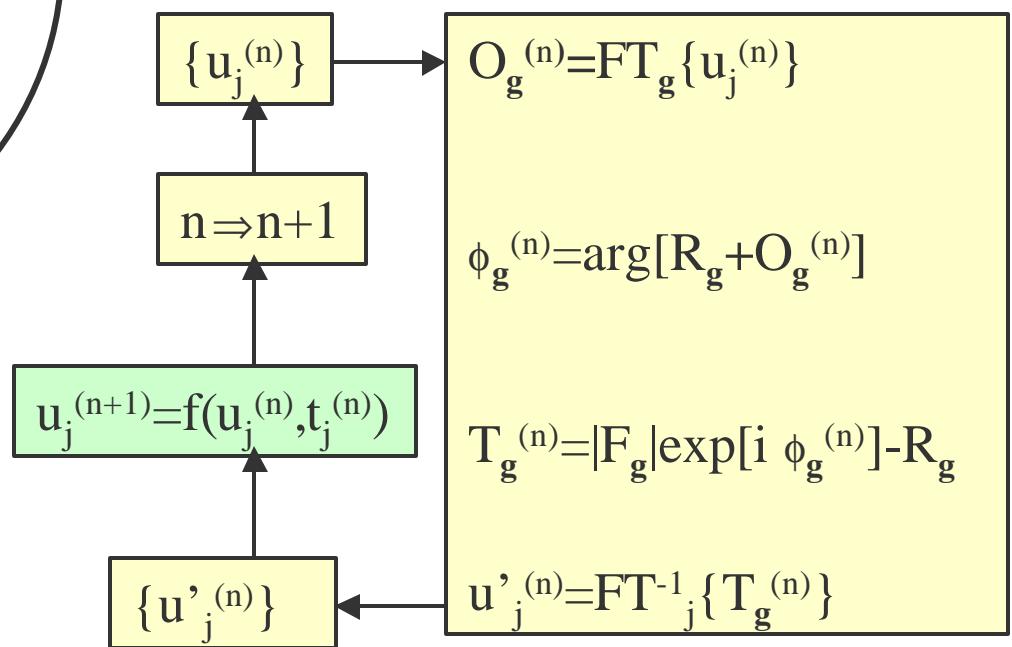
$$u_j = \frac{1}{N} \sum_g \left[ w_g |F_g| \exp\{i \phi_g^{(R)}\} - R_g \right] \exp(-g \cdot r_j)$$

$$w_g = f(X_g)$$

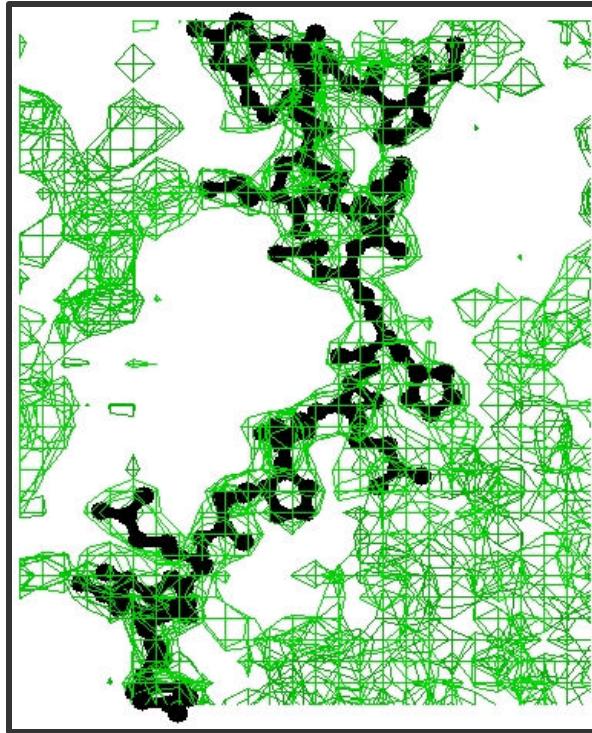
$$X_g = 2 |F_g| |R_g| / \sum_j f_j^2$$



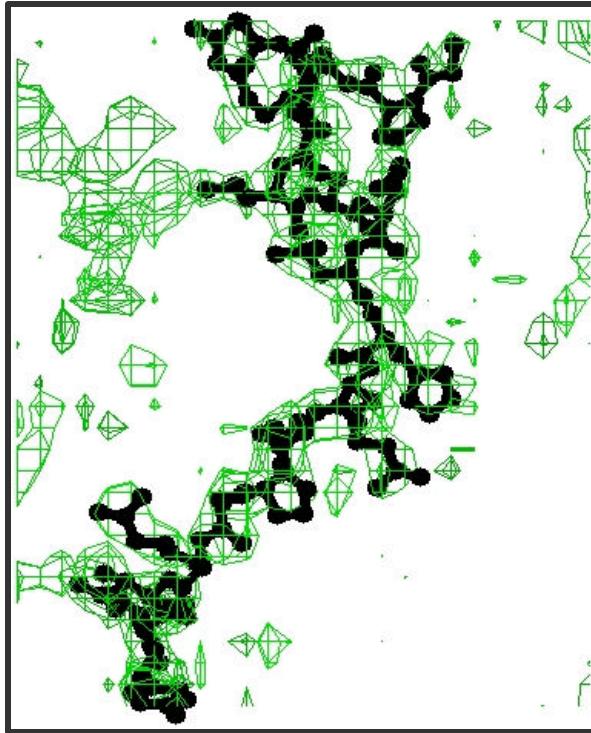
## Fienup Algorithm for Structure Completion



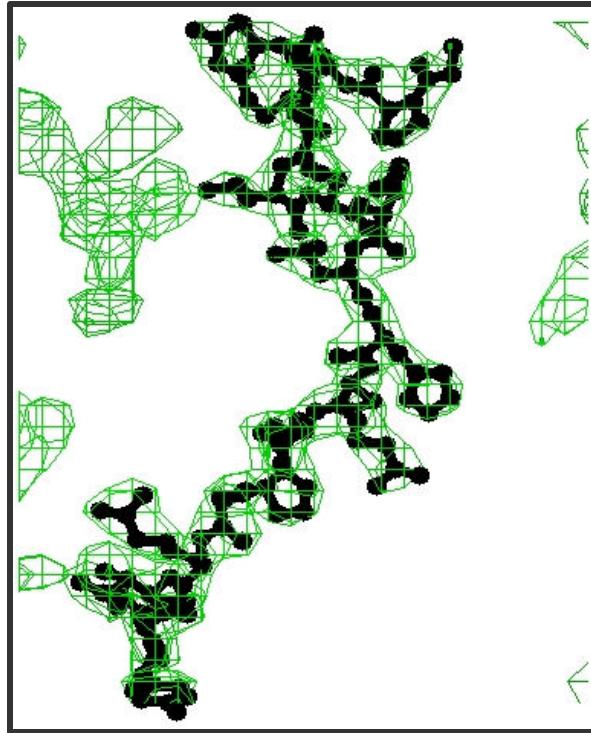
## TOXD: Recovery of residues 1-18



DF  
 $1.3\sigma + \text{mean}$



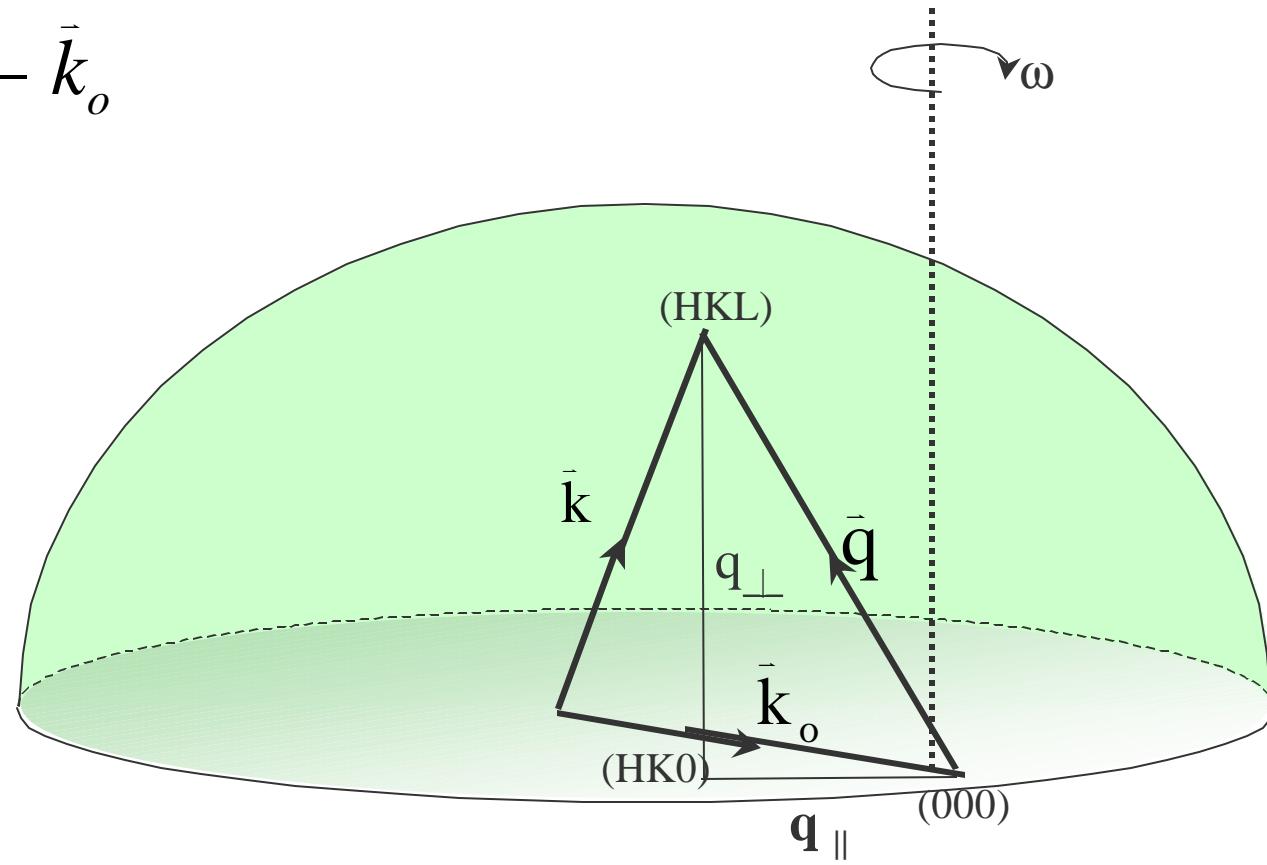
Fienup  
 $2.2\sigma + \text{mean}$



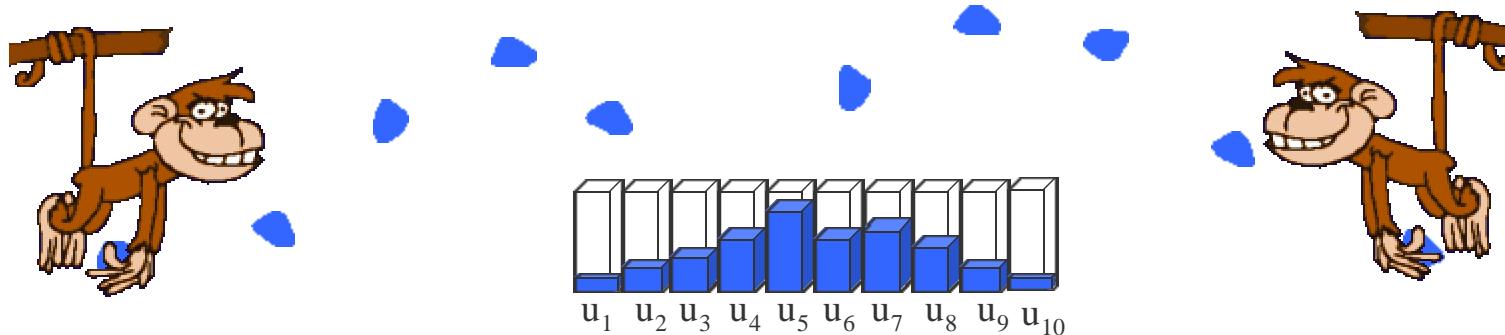
Exact  
 $2.9\sigma + \text{mean}$

## Ewald sphere construction for surface x-ray diffraction

$$\bar{q} = \bar{k} - \bar{k}_o$$



## Prior Probability of a Distribution and its Entropy



Consider a team of monkeys (unbiased individuals) throwing objects at random into boxes  $1, 2, 3, \dots$  of capacities  $m_1, m_2, m_3, \dots$ , respectively.

The probability of particular distribution  $\{u_1, u_2, u_3, \dots\}$  is proportional to number of ways it can come about:

$$P(\{u_j\}) = \bar{U} = \prod_j m_j^{u_j} / \prod_j u_j! \quad \text{But} \quad S = k \log \bar{U}$$

Therefore  $P(\{u_j\}) \propto \bar{U} = \exp(S/k)$

Hence most probable distribution is that of the maximum entropy

## Boltzmann and Gibbs Forms of the Entropy

$$S = k \ln(\Omega)$$

Boltzmann

$$\dot{\Omega} = \prod_j m_j^{u_j} / \prod_j u_j!$$

Stirling's Approximation

$$\ln(u_j!) = u_j \ln(u_j) - u_j$$

$$\ln(\Omega) = \sum_j u_j \ln(m_j) - \sum_j u_j \ln(u_j) + \sum_j u_j \ln(e)$$

$$S = -k \sum_j u_j \ln(u_j / e m_j)$$

Gibbs

## Maximization of the Constrained Entropy

$$Q = -\sum_{l=1}^N u_l^{(n+1)} \ln[u_l^{(n+1)} / e u_l^{(n)}] - \frac{\ddot{e}}{2} \sum_q \left| F_q \left| e^{i \ddot{o}_q^{(n)}} - [R_q + FT_q \{ u_l^{(n+1)} \}] \right| \right|^2$$

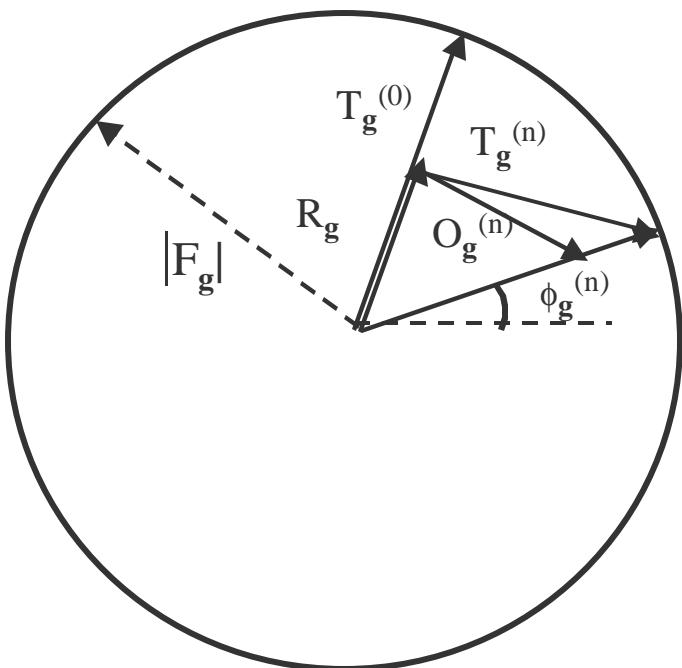
$$\partial Q[\{u_l^{(n+1)}\}] / \partial u_j^{(n+1)} = -\ln[u_j^{(n+1)} / u_j^{(n)}] - \ddot{e}[u_j^{(n)} - u_j^{(n+1)}] = 0$$

$$u_j^{(n+1)} = u_j^{(n)} e^{-\ddot{e}\{u_j^{(n)} - u_j^{(n)}\}}$$

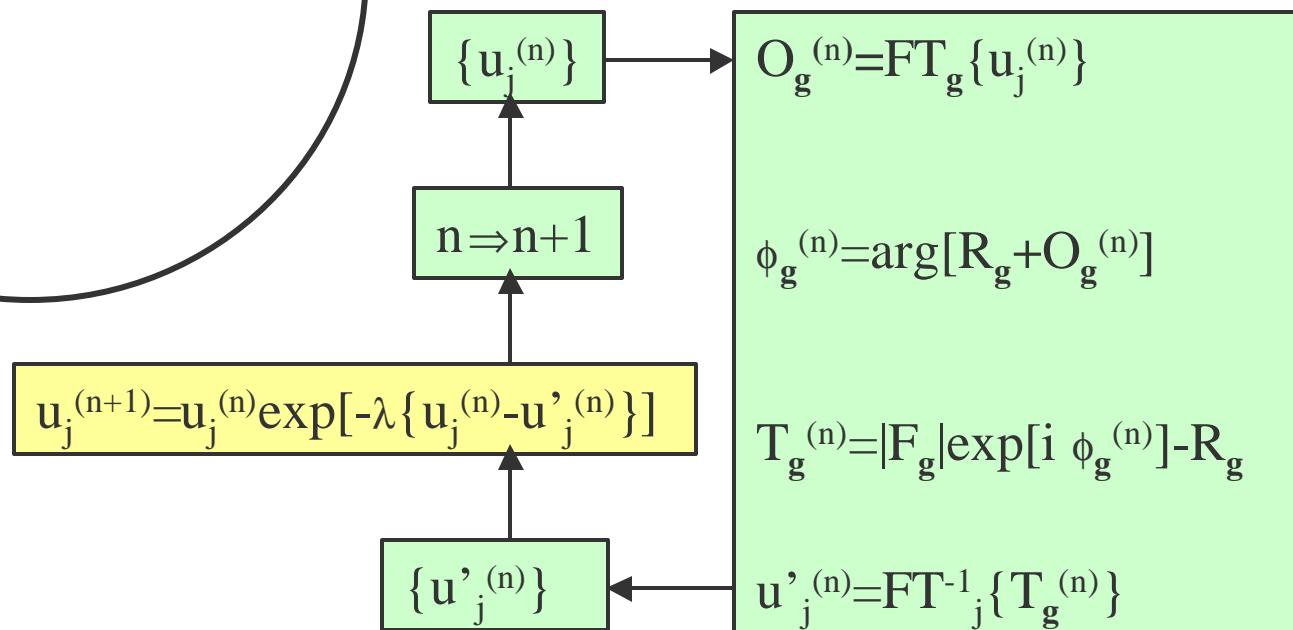
*Exponential Modeling Algorithm: Collins Nature 298, 49 (1982)*

$$u_j^{(n)} = FT_j^{-1} [F_q |e^{i \ddot{o}_q^{(n)}} - R_q|]$$

$$\ddot{o}_q^{(n)} = \arg\{R_q + FT_q(u_j^{(n)})\}$$



## Exponential Modeling Algorithm for Structure Completion



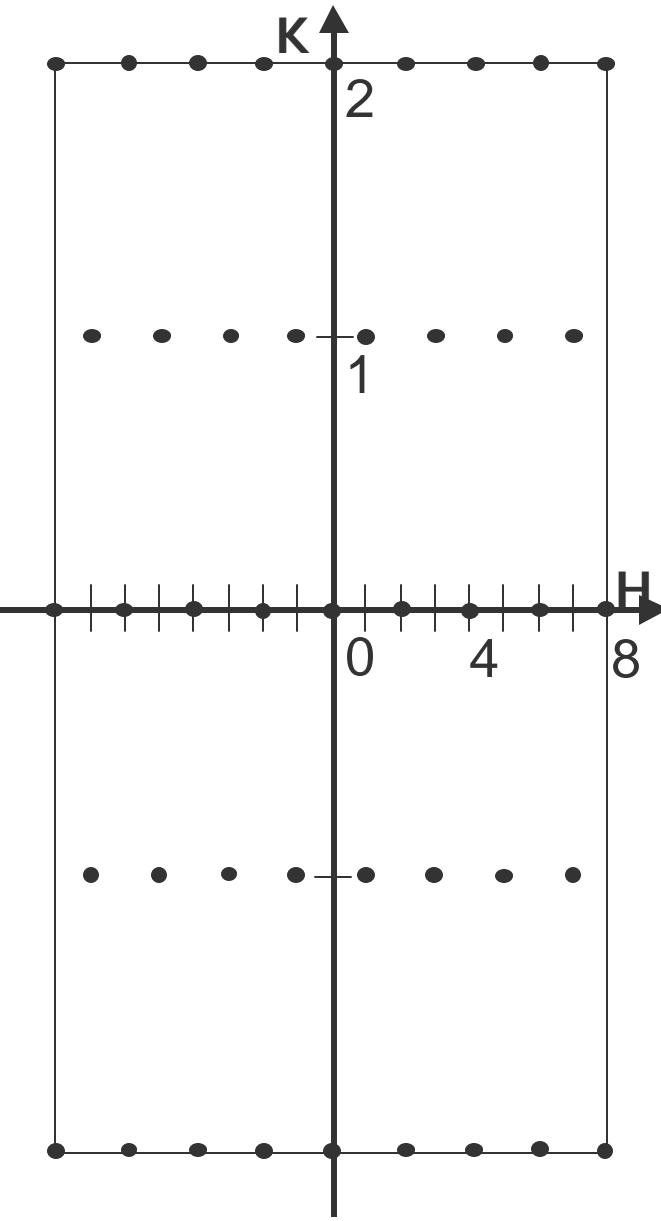
**Proteins:** Shneerson, Wild, Saldin *Acta Cryst. A* **57** 163 (2001)

**Surfaces:** Saldin, Harder, Vogler, Moritz, Robinson

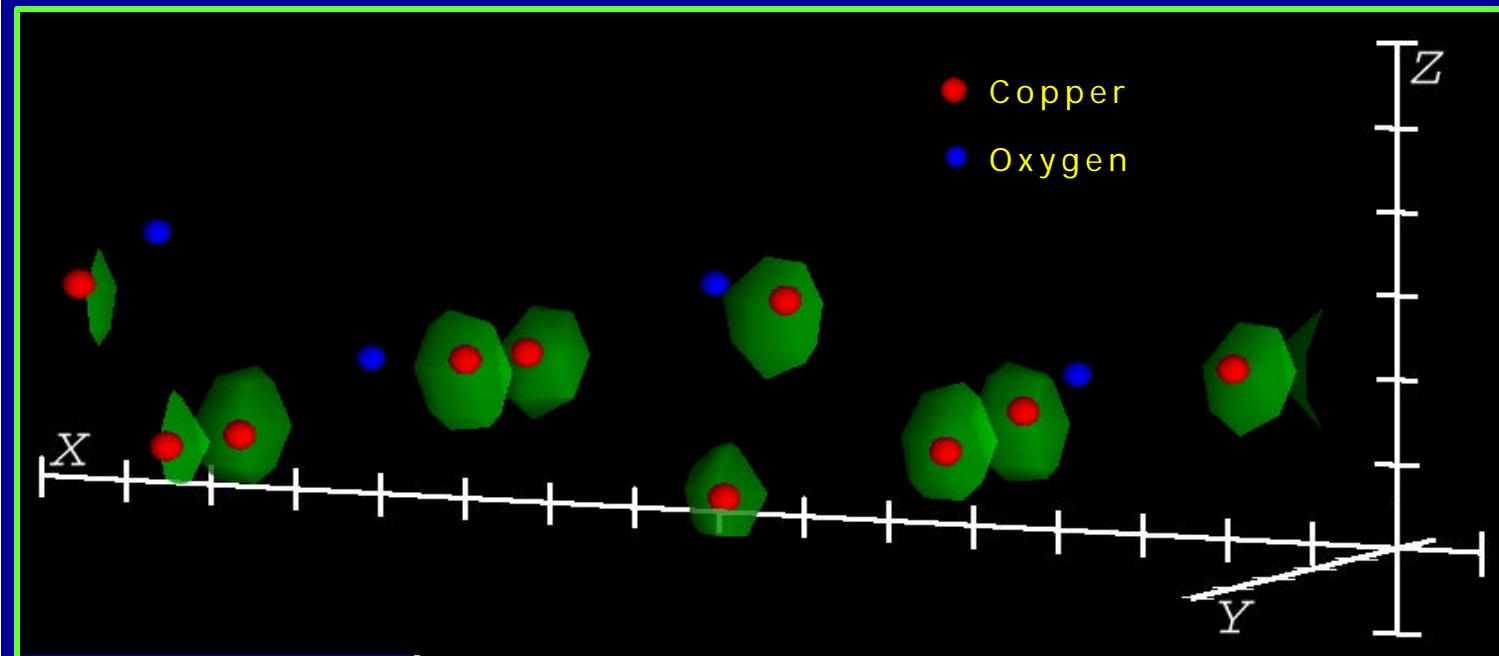
*Comput. Phys. Commun.* **137** 12 (2001)

# Diffraction pattern

O/Cu(104)

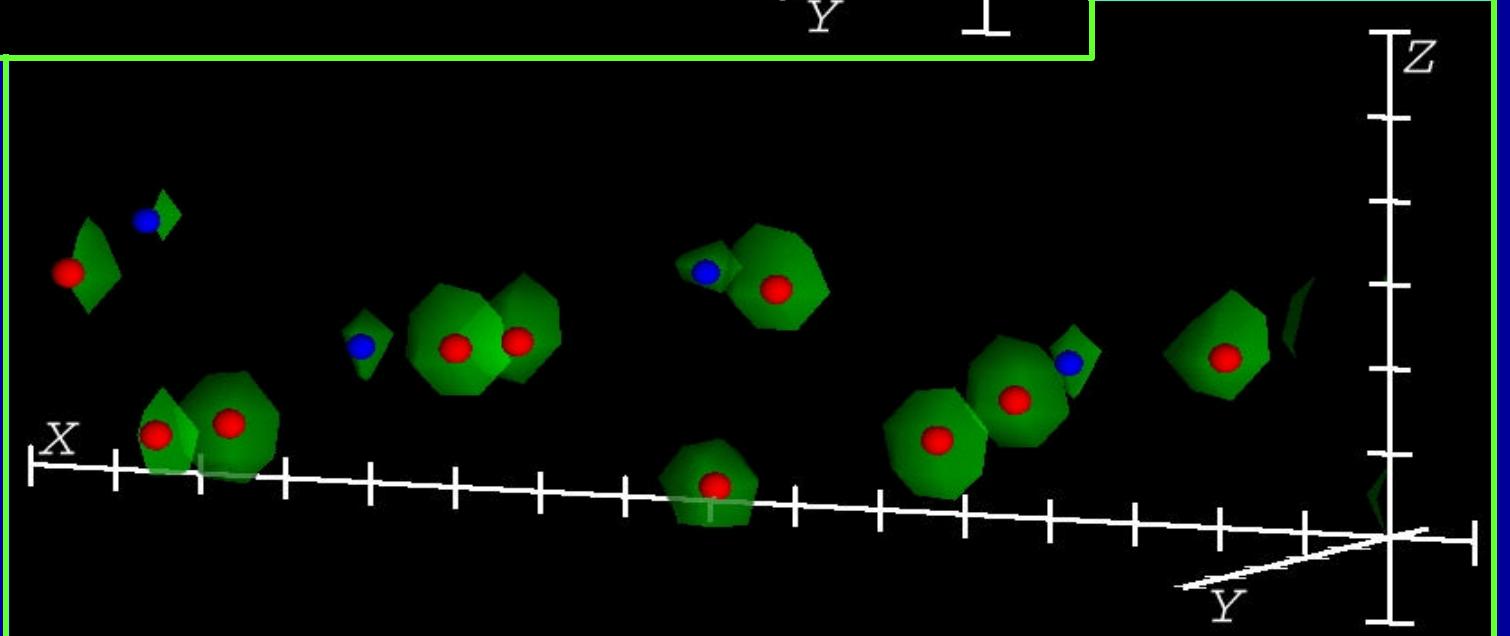


O/Cu(104)



Difference  
Fourier

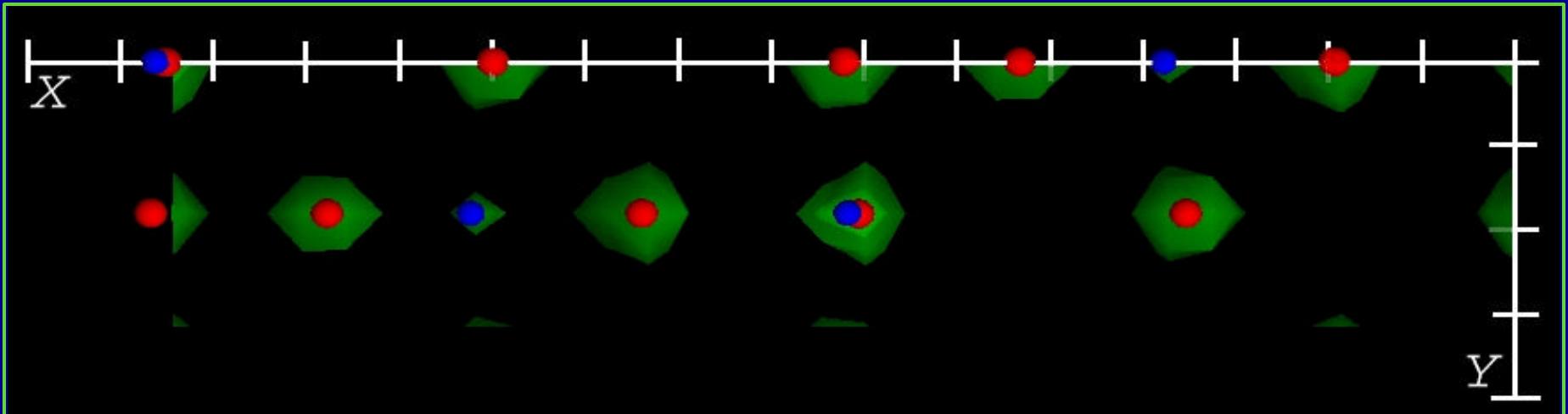
Exponential  
Modeling



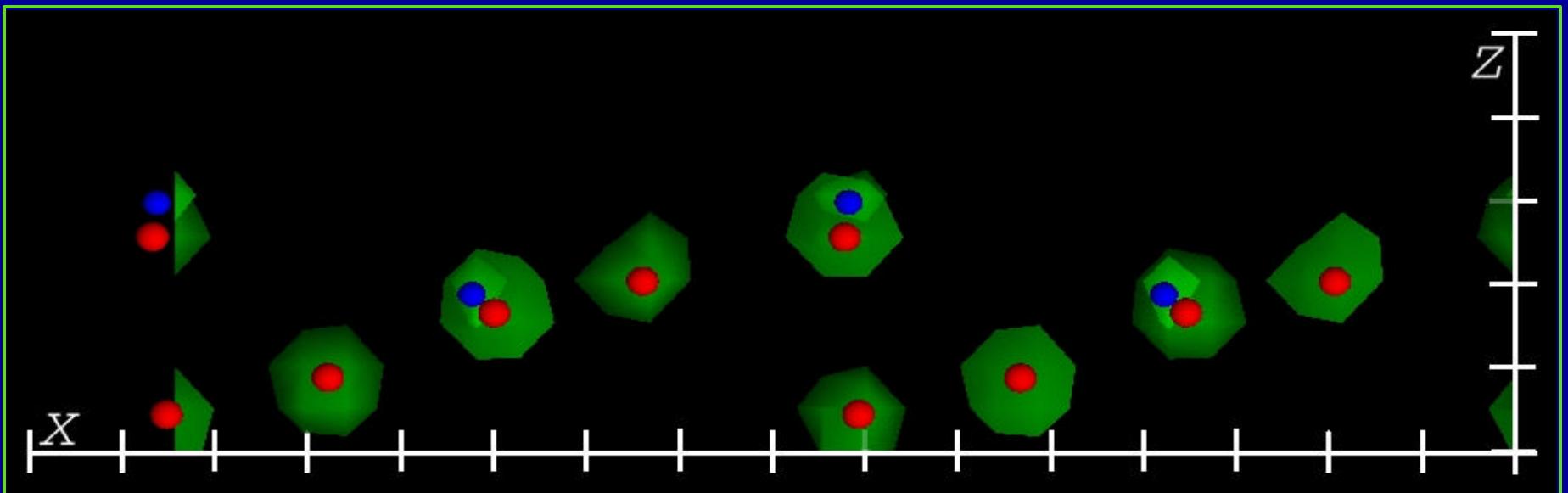
O/Cu(104)

Exponential Modeling

Top View

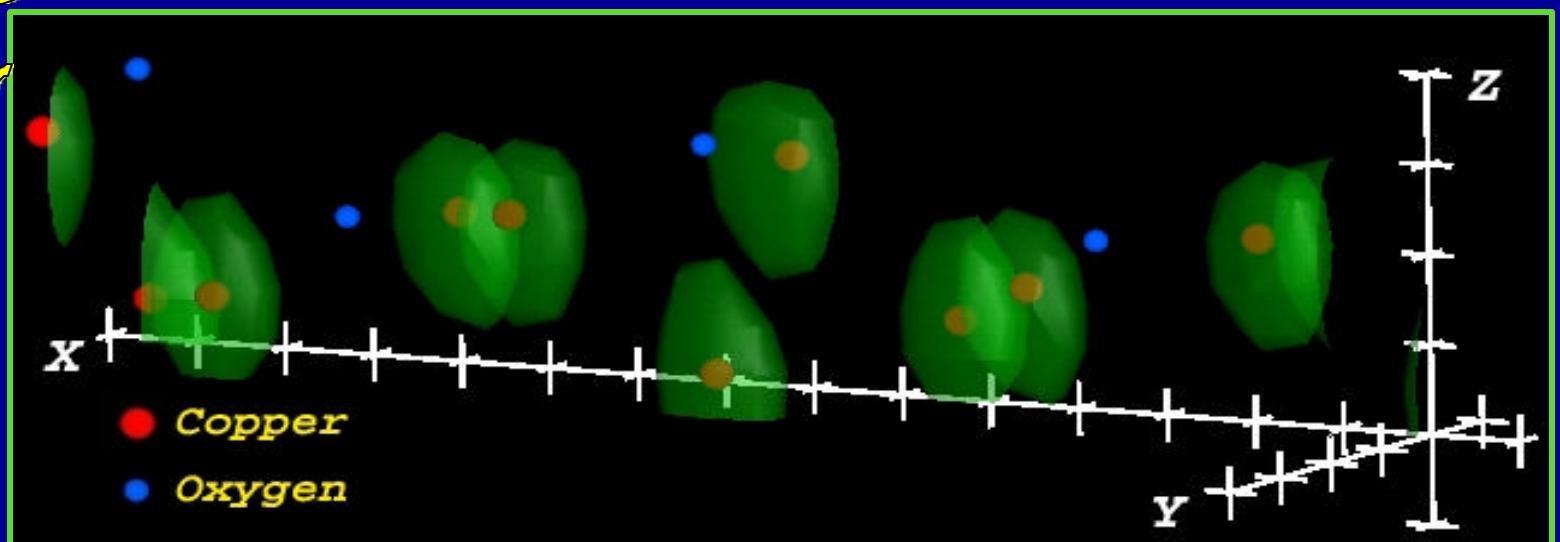


Side View

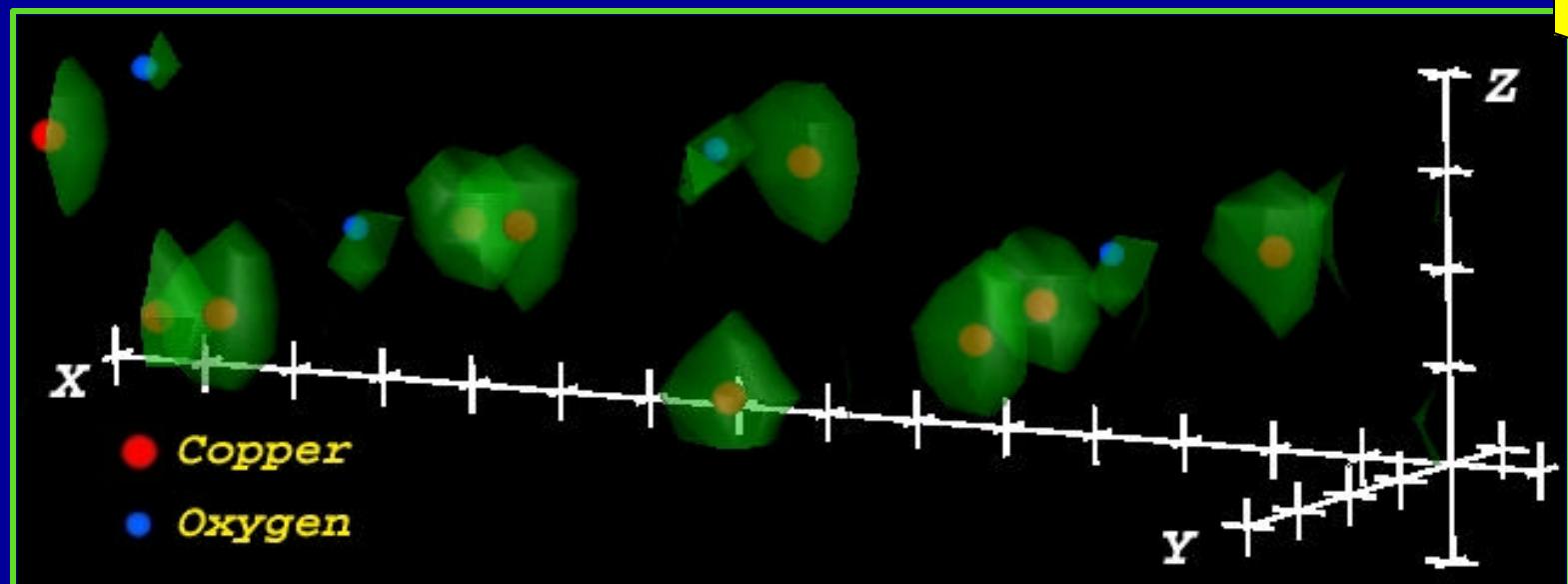


O/Cu(104)

Difference  
Fourier



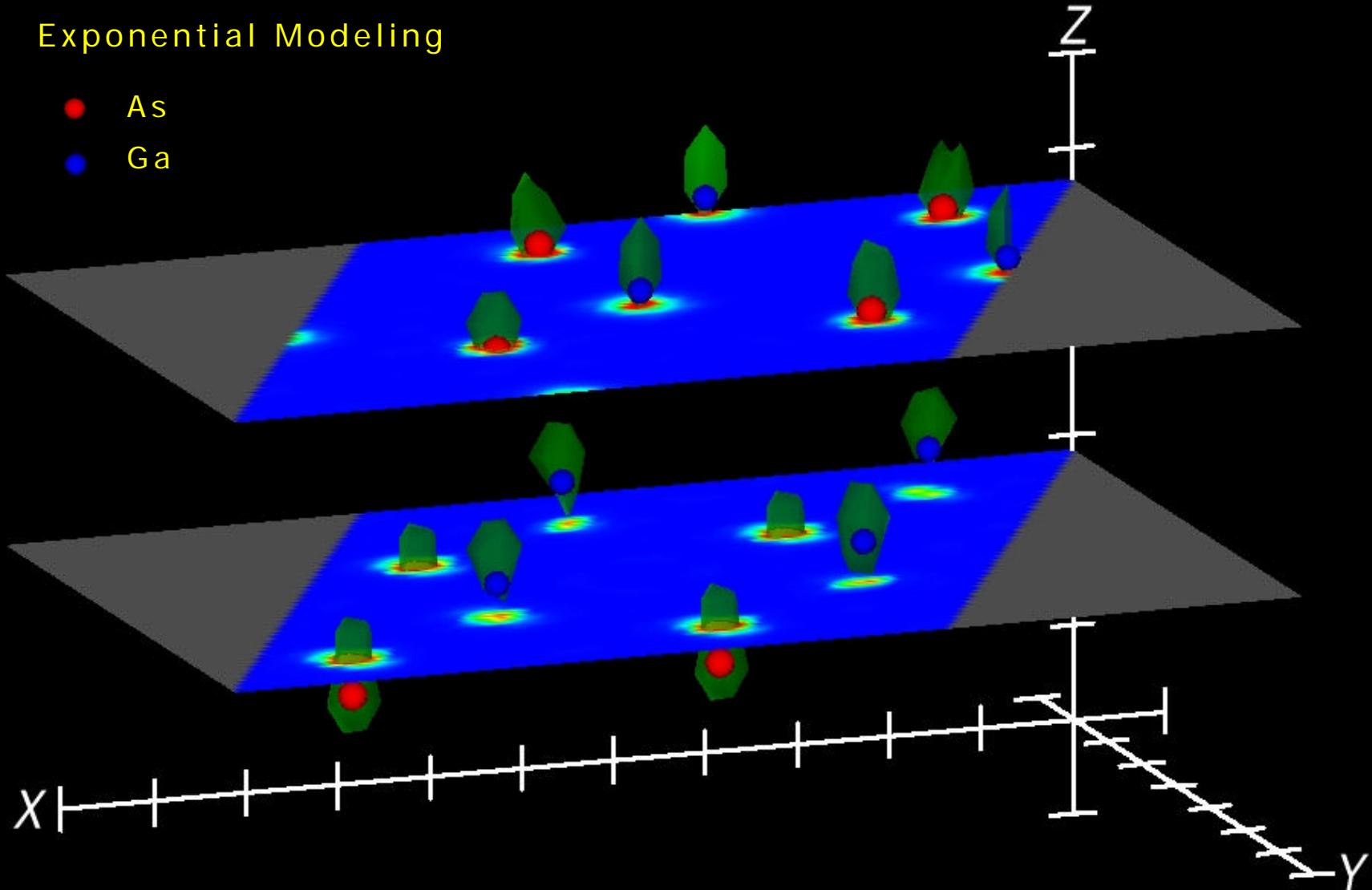
Fienup  
Result



**GaAs(111)2x2**  
**Vacancy buckling model**

Exponential Modeling

- As
- Ga



## Conclusions

1. The Fienup algorithm may be adapted very effectively to the *structure completion* problem in protein and surface crystallography.
2. Collins' exponential modeling algorithm may be re-cast as a Fienup-type input-output feedback loop between real and reciprocal space.
3. Surface crystallography is by its nature a structure completion problem.
4. Either algorithm seems very effective in recovering the surface electron density from surface x-ray diffraction (SXRD) measurements given a knowledge of the bulk structure.